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The Na-SrSiO₃ is a mixture of lightly Na-doped SrSiO₃ and amorphous $Na_2Si_2O_5$

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On the Cause of Conductivity Degradation in Sodium Strontium Silicate Ionic Conductor

Received 00th January 20xx, Accepted 00th January 20xx

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DOI: 10.1039/x0xx00000x

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Here we present strong experimental evidence that elucidates the fundamental cause for the conductivity degradation observed in Na-SrSiO₃ ionic conductor.

Recent reports by Singh et al. on a new family of ionic conductors bearing a generic formula of $Sr_{1-x}A_xMO_{3-0.5x}$ (A = K or Na and M = Si or Ge) have sparked a heated debate on the nature of ionic conduction [1, 2]. Singh et al. originally postulated from hightemperature neutron diffraction data that the oxygen vacancies were created through Sr-site doping by Na and became mobile at a temperature >400°C, thus leading to oxide-ion conduction [3]. While the oxide-ion conduction mechanism in $Sr_{0.7}K_{0.3}SiO_{2.85}$ was partially supported by NMR and neutron diffraction data provided by Xu et al. [4], others instead argued that this material was essentially a mixture of a crystalline phase and amorphous phase [5-9]. A critical work by Bayliss et al. showed from an experimental and theoretical perspective that substitution of Na or K into Sr sites is an energetically unfavourable process [5, 6]. A subsequent oxygen isotope exchange and SIMS measurement on the $Sr_{0.8}K_{0.2}Si_{0.5}Ge_{0.5}O_{2.9}$ sample indicated a very low oxygen-ion diffusivity [5]. By using NMR, Evans et al. further identified that the crystalline and amorphous phases in the $Sr_{1-x}Na_xSiO_{3-0.5x}$ were $SrSiO_3$ and $Na_2Si_2O_5$, respectively. It was also found that the conductivity increased with the amount of amorphous phase Na₂Si₂O₅ present in the sample, which was also proportional to the Na-content [7]. Similarly, Tealdi et al. and Fernández-Palacios et al. confirmed that the amorphous $Na_2Si_2O_5$ phase was responsible for the ionic conduction [8, 9].

Among these mechanistic studies on ionic conduction, Bayliss *et al.* [6] first reported the conductivity degradation phenomenon in a Sr_{1-x}Na_xSiO_{3-0.5x} (x=0.45) sample although the causes for the degradation were not specifically discussed in the paper. We have also observed a similar conductivity degradation behaviour of the

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DOI: 10.1039/x0xx00000x

same composition in our recent independent study. Herein we present a strong evidence that unambiguously elucidates the fundamental cause for the degradation. The x=0.45 was particularly selected since it has been the most studied composition.

	Bright	at%	ratio	
and the second of	οк	59.14	-	-
Gak 207 34 14	Na K	1.18	6.8	12.2
The Part of the second	Sr L	16.1	93.2	42.5
A Manhood - The of	Si K	23.58	H	57.7
	Dark	at%	ratio	
A CARDEN	ОК	60.79	-	-
1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1	Na K	18.73	99.8	47.0
M	Sr L	0.03	0.2	47.8

Fig. 1 SEM image and EDX analysis of the x=0.45 sample

The two-phase nature of the x=0.45 sample as reported by other researchers is confirmed by Fig.1; there are clearly a liquid-like dark phase mixed with a crystalline-like bright phase in the SEM image. The EDX analysis indicates that the dark phase has an average chemical composition of Na:Si≈1:1 with a very low concentration of Sr, implying a likely Na₂Si₂O₅ composition. By contrast, the bright phase has a very low concentration of Na (~6.8 at%), but a high and similar concentration of Sr and Si, suggesting that SrSiO₃ with a minor doping by Na be the composition. While prepared as x=0.45, it is evident that the majority of Na did not enter Sr-sites as expected, but segregated out to form molten Na₂Si₂O₅ (T_m=848.8°C) at the synthesis temperature of 900°C. These findings are generally consistent with those reported by Bayliss, [5, 6], Ivana [7] and Tealdi [8].

J. Name., 2013, 00, 1-3 | 1



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[†] Electronic Supplementary Information (ESI) available: Sample preparation, material characterization and electrical conductivity measurement details. See

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The Arrhenius plot of conductivity of the x=0.45 sample is shown in Fig.2 (a), which also includes those measured from the amorphous and crystalline Na₂Si₂O₅ samples for comparison. One distinctive feature is the curve bend-over for the x=0.45 and amorphous Na₂Si₂O₅ (AM-Na₂Si₂O₅) samples, although the bend-over occurs at different temperatures: 600°C for the x=0.45 sample and 500°C for the AM-Na₂Si₂O₅. By contrast, the crystalline Na₂Si₂O₅ (C-Na₂Si₂O₅) sample did not show any bend-over. The bend-over behaviour is later determined to originate from the time-dependence of conductivity of these two samples; the evidence is given in Fig.2 (b). Nevertheless, one important information gained from Fig.1 (a) is that the AM-Na₂Si₂O₅ has a higher intrinsic conductivity than the x=0.45 and C-Na₂Si₂O₅ samples and C-Na₂Si₂O₅ is an electrical insulator.



Fig. 2 (a) Arrhenius plot and (b) time-dependent plot of conductivity for the x=0.45, AM- and C- $Na_2Si_2O_5$ samples, respectively.

The time dependence of the conductivity for the x=0.45 and AM-Na₂Si₂O₅ samples measured at 500°C and in air is shown in Fig.2 (b). It is evident that the conductivity of the x=0.45 sample exhibits a steady-state degradation over a period of 450 hours. In contrast, the initially high conductivity of the AM-Na₂Si₂O₅ experiences a sharp drop in the first 24 hours, followed by a gradual stabilization to a value close to the x=0.45 sample. The resemblance in the final conductivity between the two samples signals that the original conducting and final less-conducting phases are similar in chemical

composition, viz. amorphous and crystalline $Na_2Si_2O_5$, respectively; the latter phase transition will be further discussed in the following.

One reasonable hypothesis that can explain the above results is that the original high-conductivity $AM-Na_2Si_2O_5$ gradually crystalizes into the low-conductivity $C-Na_2Si_2O_5$ at elevated temperatures. To prove this hypothesis, we conducted a high-temperature XRD study. Fig.3 shows the phase evolution of the x=0.45 and $AM-Na_2Si_2O_5$ samples. The crystalline phase in the x=0.45 sample can be indexed into a SrSiO₃ phase (PDF No. 36-0018, c2/c, space group (15)) as reported by Singh *et al.* [1-3]. More importantly, Fig.3 (a) indicates that the x=0.45 sample precipitates out a new phase RC-Na_2Si_2O₅, a polymorph of Na_2Si_2O₅ (PDF No. 19-1233), at 600°C. In comparison, the pure AM-Na_2Si_2O₅ also crystalizes into the RC-Na_2Si_2O₅ phase at lower 550°C, further proving that the crystallization of AM-Na_2Si_2O₅ is a thermodynamically favourable process; the RC-Na_2Si_2O₅ is a more stable phase at elevated temperatures.



Fig. 3 Phase evolution of the x=0.45 (a) and AM-Na₂Si₂O₅ (b) samples with temperature. ("*" in red: RC-Na₂Si₂O₅, "+": SrSiO₃)

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The crystallization of amorphous Na₂Si₂O₅ is further supported by an independent DSC study. Fig.4 shows a DSC diagram measured from the AM-Na₂Si₂O₅ and x=0.45 samples. Ignoring the desorptionrelated peaks at T<400°C, exothermic heat flows corresponding to the crystallization start at ~ 490°C and peak at 550 and 650°C for the AM-Na₂Si₂O₅ and x=0.45 samples, respectively. These glass-toceramic transition temperatures match well those indicated by HT-XRD spectra shown in Fig.3, implying that the nature of these thermal peaks are related to the crystallization process. The disappearance of thermal peaks during cooling suggests that the crystallization process is irreversible and C-Na₂Si₂O₅ is a thermodynamically more stable phase. The smaller magnitude of heat flow for the x=0.45 sample (dotted line) is due to less amount of the AM-Na₂Si₂O₅ in the material.



Fig. 4 DSC diagram measured from the AM-Na_2Si_2O_5 and x=0.45 samples in air

In conclusion, the present study has again confirmed that the Sr₁. $_x$ Na_xSiO_{3-0.5x} system is a two-phase material consisting of a crystalline SrSiO₃ phase with minor Na-doping and amorphous Na₂Si₂O₅ phase. An independent conductivity study showed that the AM-Na₂Si₂O₅ is a highly conductive ionic conductor. While the nature of ionic conduction in terms of O²⁻ vs Na⁺ has not been fully understood at the present time, this study explicitly shows that the AM-Na₂Si₂O₅ is a thermodynamically unstable phase at elevated temperatures, transforming into a crystalline form that is an electrical insulator. It is the amorphous-to-crystalline phase transformation in the highly conductive AM-Na₂Si₂O₅ at elevated temperatures that causes the conductivity degradation observed.

Notes and references

This work was funded by the Advanced Research Projects Agency-Energy (ARPA-E), U.S. Department of Energy, under Award number DE-AR0000492. The authors would also like to thank Xiaolei Xiong for helping prepare samples, Cong Ren for conducting DSC measurement and Jeongho Yeon for performing XRD measurements with very helpful discussions.

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